

**Search Notes**

Application/Control No.

10/733,409

Examiner

Y Quach Lee

Applicant(s)/Patent under  
Reexamination

TAKAHASHI, SHINJI

Art Unit

2875

**SEARCHED**

Class	Subclass	Date	Examiner
362	473 505 506 507 540 541 543 549	5/26/2005	YMY

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
NONE	5/26/2005	YMY